


<b>Search Notes</b> 	<b>Application/Control No.</b> 10660641	<b>Applicant(s)/Patent Under Reexamination</b> SEGAWA ET AL.
	<b>Examiner</b> Carter, Aaron W	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	115-127, 181	5/25/07	AWC
340	5.1, 5.2, 5.52, 5.53	5/25/07	AWC
902	3	5/25/07	AWC
713	186	5/25/07	AWC
Updated Above		9/27/07	AWC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text Search (USPAT, PGPUB) See Search History Printout	5/25/07	AWC
Inventor Name Search (See PALM Search History Printout)	5/25/07	AWC
IEEE (See Search History Printout)	5/25/07	AWC
Updated EAST Text Search (USPAT, PGPUB, DERWENT) See Search History Printout	9/27/07	AWC
Updated Inventor Name Search, See PALM Search History Printout	9/27/07	AWC
Interference Search History Printout	9/27/07	AWC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
PGPUB Text Search		9/27/07	AWC